# R&S®NRQ6 Frequency Selective Power Sensor A milestone in power measurements





Product Brochure | Version 03.00

# R&S®NRQ6 Frequency Selective Power Sensor At a glance

The R&S®NRQ6 combines the accuracy of a power meter with excellent dynamic range. It performs extremely precise and fast power measurements down to -130 dBm.

The R&S®NRQ6 is based on receiver technology and can perform band-limited power measurements – i.e. power measurements on a selected transmission channel – down to –130 dBm. The R&S®NRQ6 delivers high-precision, high-speed measurements beyond the limits of currently available power meters.

In addition to conventional continuous average measurements, the R&S®NRQ6 has a trace display function and also performs ACLR measurements – a common mobile communications application. Using the optional R&S®NRQ6-K1 I/Q data interface, I/Q data can be downloaded from the power sensor to a PC for further analysis. Using additionally the R&S®NRQ6-K3 phase coherent measurements option, complex phase coherent measurements can be carried out by configuring one master R&S®NRQ6 and one or multiple slave R&S®NRQ6.

The R&S<sup>®</sup>NRQ6 is controlled via LAN, requiring power over Ethernet (PoE+). The sensor's integrated web server makes it possible to operate the GUI without any extra software – all that is needed is a PC with a web browser. The intuitive GUI is well structured and easy to operate thanks to diverse autoset functions.



### **Key facts**

- I Frequency selective power measurements
- I Frequency range: 50 MHz to 6 GHz
- I Power measurement range: -130 dBm to +20 dBm
- I Automatic frequency and bandwidth detection
- I 100 MHz measurement bandwidth
- I Continuous average, trace and ACLR measurements
- I/Q data capturing for RF vector signal analysis
- Phase coherent measurements for low-power modulated signals

# Benefits

# **Diverse measurement functions**

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Easy operation

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### Applications ▷ page 7

High measurement speed at lowest signal levels ▷ page 8



# Diverse measurement functions

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Signal analysis with R&S®QuickStep test executive software

# Continuous average power measurements down to -130 dBm - precise and fast

Conventional diode power sensors reach their physical limits at approx. –70 dBm. Fast measurements degrade accuracy, especially at low power levels, since the noise content measured by these sensors is relatively high. As a result, either speed or accuracy has to be sacrificed.

The receiver based architecture of the R&S®NRQ6 eliminates this problem. This concept lowers measurement noise. In addition, the sensor's ability to perform band-limited measurements reduces the noise floor. These characteristics enable high-precision, high-speed measurements down to –130 dBm.

### I/Q data capturing for RF vector signal analysis

The R&S®NRQ6 can be used as a standalone RF frontend to capture vector-modulated I/Q signals.

With the optional R&S<sup>®</sup>NRQ6-K1 I/Q data interface, captured I/Q data can be read out using SCPI commands. The data is demodulated and analyzed using external software.

Automated, cloud based data processing and analysis is also possible using the R&S®Quickstep test executive software to control any analysis tool in order to measure error vector magnitude (EVM), adjacent channel leakage ratio (ACLR) and other TX performance parameters.

♦ NRQ6- <sup>2</sup>	101445								Serial Number: 1 Firmware Versio	01445 h: 02.00.19011101	
Autoset	Freq	uency	Filter / Ba	ndwidth	Attenuator						
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Trace measurement on a pulsed signal

#### **Trace measurements**

A detailed trace display is necessary for precise analysis of short pulses. With an inherent rise/fall time of 13 ns at a resolution bandwidth of 50 MHz, for example, the R&S®NRQ6 can easily measure steep-edged pulses.

#### **Ultrafast triggered measurements**

Triggered measurements in particular call for ever higher measurement speeds over an extended period of time. The R&S®NRQ6 contains a powerful FPGA and a large memory to meet these requirements. More than 100 000 triggered readings can be stored in a buffer in 200 ms – corresponding to a measurement speed of 500 000 readings/s – and transferred to a control PC.

#### **Easy ACLR measurements**

The frequency selective power sensor is perfect for adjacent channel leakage ratio (ACLR) measurements, which are frequently required in mobile communications. The ACLR measurement function is accessible from the web GUI and automatically sets one of the predefined 3GPP or LTE filters. The R&S®NRQ6 achieves an ACLR performance of typically –63 dBc for a 20 MHz LTE signal at –20 dBm.



ACLR measurement on a 3.84 MHz 3GPP signal

# **Easy operation**

### **Intuitive web GUI**

The R&S<sup>®</sup>NRQ6 is connected to the LAN via a PoE+ switch. The sensor includes an integrated web server. The intuitive web GUI can be operated from any web browser.

# **Diverse autoset functions**

Diverse autoset functions are available to simplify configuration of the main measurement parameters. The measurement frequency and signal bandwidth are automatically determined and set. As a result, even unknown signals are detected and average power is measured accurately.

Depending on the input level, the 30 dB RF input attenuator is automatically switched on or off to configure the optimal power measurement range.

The trace mode also offers autoset functions. For example, the time scale (x-axis) and the power scale (y-axis) can be optimally configured. A trigger is set automatically, ensuring stable display of the measured signal.

# Automatic frequency tracking

A frequency tracker automatically sets the center frequency to facilitate measurements on narrowband signals with varying center frequency. This ensures that the measured signal is always within the selected measurement bandwidth.

## Spectrum display for signal check

Since power measurements are performed only in the set frequency range (defined by the center frequency and bandwidth), the settings must be checked to make sure they are correct. The signal check function provides a graphical display of the measured signal's spectrum and the set bandwidth. Users can see at a glance if the measured signal is within the set frequency range.

### Hardware interfaces for user convenience

The R&S<sup>®</sup>NRQ6 can be easily integrated into a test system. Remote operation is possible via LAN and USB.

The trigger I/O port can accept an external trigger signal or distribute an internally generated trigger signal to other R&S®NRQ6 power sensors.

An external LO signal can be fed to one of the R&S<sup>®</sup>NRQ6 power sensors, or the internal LO signal can be output and distributed to the other sensors.

The R&S<sup>®</sup>NRQ6 has a reference I/O port, e.g. for applying an external reference signal, and a sample clock I/O port.

signal

----- bandwidth limit

upper measurement limit





-10M

-5M

0

Frequency / Hz

5M

10M

15M

-130 -15№

# **Applications**

## **TX power calibration**

To calibrate a DUT's transmit power, it is necessary to measure the frequency response at higher levels and the linearity down to minimum levels. The R&S®NRQ6 performs both measurements. The sensor not only stands out due to its high-precision power measurements, it also features excellent linearity of 0.02 dB. The R&S®NRQ6 is a compact, single-device solution for calibrating transmit power. No additional instruments or components such as a splitter and spectrum analyzer are needed. The sensor can be directly connected to the DUT; no cable is required. This solution provides better stability, lower mismatch and higher accuracy.

# Band-limited power measurements on multistandard radios (MSR)

The R&S<sup>®</sup>NRQ6 can perform band-limited power measurements, i.e. it can measure the power on a selected transmission channel with a bandwidth up to 100 MHz, independent of neighboring channels. Band-limited power measurements can also be performed on base stations that support multiple mobile communications standards (MSR base stations), even if the user wants to measure only one standard.



Single-channel power measurement on an MSR signal

# Calibration of multiple active antenna modules for beamforming

The synchronous phase coherent measurements (R&S®NRQ6-K3 option) are based on a master/slave relationship between two or more R&S®NRQ6. The master forwards the local oscillator (LO) signal and its clock signal (CLK) to the slave(s) and triggers the slave(s). All measurement results are performed relative to the master. A calibration step before the first measurement helps eliminate the resulting group delay in the slave measurements. This is a simple and ideal solution for calibrating multiple active antenna modules for beamforming applications.



Results of an example multichannel phase difference measurement with one R&S<sup>®</sup>NRQ6 as master and eight R&S<sup>®</sup>NRQ6 as slaves. The master R&S<sup>®</sup>NRQ6 is only used for distribution of TRG, CLK and LO signals.

# High measurement speed at lowest signal levels

Every diode based power meter works without band limitation in the specified frequency range. This feature makes the sensors very flexible, but has a significant impact: the noise contribution. Precise measurement of low-power signals requires averaging of multiple measurement samples and this increases the measurement time. The diode based power meter technology is mature, and therefore only limited product innovations are possible.

Precise and fast measurement of very low power signals below –30 dBm was not possible until now. The receiver technology based R&S<sup>®</sup>NRQ6 has significantly increased the measurement speed for low-power signals.

# Comparison of measurement time for a CW signal



# **Specifications**

# Definitions

#### General

Product data applies under the following conditions:

- I Three hours storage at ambient temperature followed by 30 minutes warm-up operation
- I Specified environmental conditions met
- I Recommended calibration interval adhered to
- I All internal automatic adjustments performed, if applicable

#### Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as  $<, \leq, >, >, \geq, \pm$ , or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



#### Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

#### Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80% of the instruments at production time. Otherwise, it represents the mean value.

#### Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

#### Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

#### Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are indicated as follows: "parameter: value".

Typical data as well as nominal and measured values are not warranted by Rohde&Schwarz.

In line with the 3GPP/3GPP2 standard, chip rates are specified in Mcps (million chips per second), whereas bit rates and symbol rates are specified in Mbps (million bits per second), kbps (thousand bits per second), Msps (million symbols per second) or ksps (thousand symbols per second), and sample rates are specified in Msample/s (million samples per second). Mcps, Mbps, Msps, kbps, ksps and Msample/s are not SI units.

### R&S®NRQ6 power sensor signal flow from RF input connector to result processing



Frequency range50 MHz to 100 MHz50 MHz to 100 MHz<1.20
Impedance matching (SWR)50 MHz to 100 MHz< 1.20
> 100 MHz to 2.0 GHz< 1.13
> 2.0 GHz to 6.0 GHz       < 1.20         Power measurement range       dynamic range dependent on RBW (10 Hz to 400 MHz)       -130 dBm to +20 dBm         Damage level       max. average power       1 W (+30 dBm) continuous         max. Deak envelope power       2 W (+33 dBm) for max. 1 µs         max. DC voltage       ± 20 V         RF input attenuation       0 dB, 30 dB         Measurement subranges       RF input attenuation = 0 dB       -130 dBm to -10 dBm         Resolution bandwidth (RBW) <sup>11</sup> single-sideband (SSB) mode       10 Hz to 40 MHz         Zero IF mode (RF input frequency ≥ 400 MHz)       50 MHz, 80 MHz, 100 MHz, 400 MHz         Acquisition       sample rate       119 MHz to 121 MHz <sup>2</sup>
Power measurement range       dynamic range dependent on RBW (10 Hz to 400 MHz)       -130 dBm to +20 dBm         Damage level       max. average power       1 W (+30 dBm) continuous         max. peak envelope power       2 W (+33 dBm) for max. 1 µs         max. DC voltage       ± 20 V         RF input attenuation       0 dB, 30 dB         Measurement subranges       RF input attenuation = 0 dB         RF input attenuation = 30 dB       -100 dBm to +20 dBm         Resolution bandwidth (RBW) <sup>1</sup> single-sideband (SSB) mode         10 Hz to 40 MHz       2 ero IF mode (RF input frequency ≥ 400 MHz)         Acquisition       sample rate       119 MHz to 121 MHz <sup>2</sup> Displayed average noise level (DANL) <sup>3</sup> BE input attenuation = 0 dB
Damage level       max. average power       1 W (+30 dBm) continuous         max. peak envelope power       2 W (+33 dBm) for max. 1 µs         max. DC voltage       ± 20 V         RF input attenuation       0 dB, 30 dB         Measurement subranges       RF input attenuation = 0 dB         RF input attenuation = 30 dB       -130 dBm to -10 dBm         Resolution bandwidth (RBW) <sup>10</sup> single-sideband (SSB) mode         Single-sideband (SSB) mode       10 Hz to 40 MHz         Zero IF mode (RF input frequency ≥ 400 MHz)       50 MHz, 80 MHz, 100 MHz, 400 MHz         Acquisition       sample rate       119 MHz to 121 MHz <sup>2</sup> )
Imax. peak envelope power       2 W (+33 dBm) for max. 1 µs         max. DC voltage       ± 20 V         RF input attenuation       0 dB, 30 dB         Measurement subranges       RF input attenuation = 0 dB         RF input attenuation = 30 dB       -130 dBm to -10 dBm         Resolution bandwidth (RBW) <sup>1</sup> single-sideband (SSB) mode         2 voltage       10 Hz to 40 MHz         2 zero IF mode (RF input frequency ≥ 400 MHz)       50 MHz, 80 MHz, 100 MHz, 400 MHz         Acquisition       sample rate       119 MHz to 121 MHz <sup>2</sup> )
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Measurement subranges       RF input attenuation = 0 dB       -130 dBm to -10 dBm         RF input attenuation = 30 dB       -100 dBm to +20 dBm         Resolution bandwidth (RBW) <sup>1</sup> single-sideband (SSB) mode       10 Hz to 40 MHz         zero IF mode (RF input frequency ≥ 400 MHz)       50 MHz, 80 MHz, 100 MHz, 400 MHz         Acquisition       sample rate       119 MHz to 121 MHz <sup>2</sup> Displayed average noise level (DALL) <sup>3</sup> PE input attenuation = 0 dB
RF input attenuation = 30 dB       -100 dBm to +20 dBm         Resolution bandwidth (RBW) <sup>1</sup> )       single-sideband (SSB) mode       10 Hz to 40 MHz         zero IF mode (RF input frequency ≥ 400 MHz)       50 MHz, 80 MHz, 100 MHz, 400 MHz         Acquisition       sample rate       119 MHz to 121 MHz <sup>2</sup> )         Displayed average noise level (DANL/ <sup>3</sup> )       PF input stateputting _0 dP
Resolution bandwidth (RBW) <sup>1</sup> )     single-sideband (SSB) mode     10 Hz to 40 MHz       zero IF mode (RF input frequency ≥ 400 MHz)     50 MHz, 80 MHz, 100 MHz, 400 MHz       Acquisition     sample rate     119 MHz to 121 MHz <sup>2</sup> )       Displayed average noise level (DANL/3)     PE input attraputing _0 dP
zero IF mode (RF input frequency ≥ 400 MHz)     50 MHz, 80 MHz, 100 MHz, 400 MHz       Acquisition     sample rate     119 MHz to 121 MHz²)       Displayed average noise level (DANL)³     BE input attenuation = 0 dB
Acquisition     sample rate     119 MHz to 121 MHz <sup>2</sup> )       Displayed average noise level (DANL) <sup>3</sup> PE input attravation = 0 dP
Displayed average noise level (DANL) <sup>3)</sup>
PE input attanuation 0 dP
RF Input attenuation = 0 dB
50 MHz to 100 MHz < -148 dBm (1 Hz)
> 100 MHz to 400 MHz < -153 dBm (1 Hz)
> 400 MHz to 2.4 GHz < -156 dBm (1 Hz)
> 2.4 GHz to 6.0 GHz < -153 dBm (1 Hz)
RF input attenuation = 30 dB
50 MHz to 100 MHz < -118 dBm (1 Hz)
> 100 MHz to 400 MHz < -123 dBm (1 Hz)
> 400 MHz to 2.4 GHz < -126 dBm (1 Hz)
> 2.4 GHz to 6.0 GHz < -121 dBm (1 Hz)
Uncertainty for absolute power measurements <sup>4)</sup>
operating temperature range +20 °C to +25 °C +15 °C to +35 °C 0 °C to +50 °C
RF input attenuation = 0 dB
50 MHz to 100 MHz 0.156 dB 0.167 dB 0.211 dB
> 100 MHz to 400 MHz 0.130 dB 0.143 dB 0.192 dB
> 400 MHz to 3 GHz 0.080 dB 0.100 dB 0.163 dB
> 3 GHz to 6 GHz 0.092 dB 0.110 dB 0.169 dB
RF input attenuation = 30 dB
50 MHz to 100 MHz 0.176 dB 0.189 dB 0.237 dB
> 100 MHz to 400 MHz 0.147 dB 0.162 dB 0.216 dB
> 400 MHz to 3 GHz 0.093 dB 0.114 dB 0.183 dB
> 3 GHz to 6 GHz 0.105 dB 0.125 dB 0.190 dB
Uncertainty for relative power measurements <sup>5)</sup> between any two power levels
RF input attenuation = 0 dB
-60 dBm to -20 dBm 0.020 dB
RF input attenuation = 30 dB
-30 dBm to +10 dBm 0.020 dB

Specifications					
Internal reference frequency	accuracy	$\pm 1 \times 10^{-6}$			
Intermediate frequency (IF)	RBW ≤ 40 MHz	20 MHz to 30 MHz <sup>6)</sup>			
	RBW ≥ 50 MHz	zero IF			
IF flatness	operating temperature range	+20°C to +25°C	+15°C to +35°C	0°C to +50°C	
	<ul> <li>RF input frequency ≥ 400 MHz</li> <li>RBW ≤ 40 MHz</li> <li>RBW filter type: flat</li> <li>offset from center frequency ≤ ±0.4 RBW</li> </ul>	typ. < ±0.02 dB typ. < ±0.03 dB typ. <		typ. < ±0.08 dB	
Image response	operating temperature range	+20°C to +25°C	+15°C to +35°C	0°C to +50°C	
	50 MHz to 100 MHz	typ. < -30 dBc	typ. < -30 dBc	typ. < -25 dBc	
	> 100 MHz to 400 MHz	typ. < -45 dBc	typ. < -40 dBc	typ. < -35 dBc	
	> 400 MHz to 6 GHz	typ. < -50 dBc	typ. < -45 dBc	typ. < -40 dBc	
LO phase noise	at 1 kHz offset, measurement bandwid	dth 1 Hz, measured at LO I/O connector			
	400 MHz	typ. < -98 dBc			
	1 GHz	typ. < -92 dBc			
	2 GHz	typ. < -86 dBc			
	4 GHz	typ. < -80 dBc			
	6 GHz	typ. < -74 dBc			
LO leakage at RF input connector (	LO frequency and frequencies of harmo	onics)			
	RF input attenuation = 0 dB				
	f < 3 GHz	typ. < -55 dBm			
	$3 \text{ GHz} \le f \le 6 \text{ GHz}$	typ. < -45 dBm			
	RF input attenuation = 30 dB				
	f < 3 GHz	typ. < –75 dBm			
	$3 \text{ GHz} \le f \le 6 \text{ GHz}$	typ. < –65 dBm			
Third-order intercept point (TOI) <sup>7)</sup>					
	RF input attenuation = 0 dB				
	400 MHz	typ. > +13 dBm			
	1 GHz	typ. > +12 dBm			
	2 GHz	typ. > +10 dBm			
	4 GHz	typ. > +8 dBm			
	6 GHz	typ. > +5 dBm			
	RF input attenuation = 30 dB				
	400 MHz	typ. > +43 dBm			
	1 GHz	typ. > +42 dBm			
	2 GHz	typ. > +40 dBm			
	4 GHz	typ. > +38 dBm			
	6 GHz	typ. > +35 dBm			
Second harmonic intercept point (	SHI)				
	RF input attenuation = 0 dB				
	1 GHz	typ. > +45 dBm			
	2 GHz	typ. > +38 dBm			
	4 GHz	typ. > +30 dBm			
	6 GHz	typ. > +25 dBm			
	RF input attenuation = 30 dB				
	1 GHz	typ. > +70 dBm			
	2 GHz	typ. > +63 dBm			
	4 GHz	typ. > +55 dBm			
	6 GHz	typ. > +50 dBm			

Other characteristics				
Measurand		power of incident wave		
		power of source (DUT) into 50 $\boldsymbol{\Omega}$		
RF input connector		N (male)		
Measurement functions		<ul> <li>continuous average</li> <li>trace</li> <li>adjacent channel leakage ratio (ACLR)</li> <li>I/Q trace</li> </ul>		
Continuous average function	measurand	average power over acquisition interval		
	aperture	8.3 ns to 30 s (depending on RBW)		
	duty cycle correction <sup>8)</sup>	0.001% to 100.0%		
	capacity of measurement buffer9)	1 reading to 8192 readings		
Trace function	measurand	average power over pixel(s)		
	acquisition			
	length	8.3 ns to 30 s (depending on RBW)		
	start (referenced to delayed trigger)	-15.0 s to $+15.0$ s (depending on RBW)		
	result			
	number of pixels	1 to 8192		
	resolution	$\geq$ 8.3 ns (sample period depending on RBW)		
Adjacent channel leakage ratio (ACLR)	measurand	power ratio		
	supported standards	I 3GPP (3.84 MHz) I EUTRA/LTE (5 MHz, 10 MHz, 15 N	ЛНz, 20 MHz)	
	acquisition length	1 ms to 40 ms		
	dynamic range	test model	level = –20 dBm, carrier frequency = 2 GHz	
		3GPP FDD, test model 1, 64 DPCH	–69 dBc (meas.) <sup>10)</sup>	
		EUTRA/LTE 5 MHz	–68 dBc (meas.) <sup>10)</sup>	
		EUTRA/LTE 10 MHz	–65 dBc (meas.) <sup>10)</sup>	
		EUTRA/LTE 20 MHz	–63 dBc (meas.) <sup>10)</sup>	
Phase coherent measurements	measurand	standard deviation of 10 consecutive slave R&S®NRQ6	e phase differences between two	
	supported standards	5G NR, LTE, MCCW, CW		
		MCCW signal level	temperature: +20°C signal bandwidth: 100 MHz number of carriers: 100 carrier spacing: 1 MHz center frequency: 3.5 GHz	
		–50 dBm	< 0.05° (meas.)	
		–60 dBm	< 0.08° (meas.)	
		–70 dBm	< 0.16° (meas.)	
		–80 dBm	< 0.40° (meas.)	



R&S®NRQ6 ALCR performance at 2 GHz over power; EUTRA/LTE 20 MHz (meas., noise correction on)

Other characteristics		
I/Q trace function	measurand	I/Q complex voltage
	prerequisite	R&S®NRQ6-K1 option
	acquisition length	8.3 ns to 30 s (depending on RBW)
	result	
	output sample rate	100 Hz to 120 MHz (continuously variable, impacts effective RBW)
	number of I/Q pairs	1 to 15000000
Triggering	supported measurement functions	continuous average, trace, I/Q trace
	source	<ul> <li>INTernal: internal test signal</li> <li>EXTernal2: coaxial trigger I/O (SMA (f) jack)</li> <li>EXTernal[1]: host interface trigger signal (8-pin male M12 connector)</li> <li>BUS: remote control event (*trg)</li> </ul>
	dropout	0 s to 10 s (depending on RBW)
	slope (external, internal)	positive/negative
	delay	-5 s to +10 s <sup>11)</sup> (depending on RBW)
	hold-off	0 s to 10 s (depending on RBW)
	resolution (delay, hold-off, dropout)	$\geq$ 8.3 ns (depending on RBW)
	INTernal trigger threshold level	
	range	-110 dBm to +20 dBm
	accuracy	identical to uncertainty for absolute power measurements
	hysteresis	0 dB to 10 dB
	trigger jitter	<ul> <li>internal trigger: ≥ 8.3 ns (depending on RBW)</li> <li>external trigger: 8.3 ns</li> </ul>
Averaging filter	parameters	
	supported measurement functions	continuous average, trace
	averaging count	1 to 65 536
	result output	
	moving mode	continuous result output, independent of averaging count
	repeat mode	final result only
RF input attenuation correction	function	corrects the measurement result using a fixed factor (dB offset)
	range	-200 dB to +200 dB
Host interface (8-pin male M12 co USB interface to PC via R&S*NRP-ZI USB interface to PC via R&S*NRP-ZI	<b>nnector)</b> KU interface cable (requires additional F K6 interface cable + R&S®NRP-Z5 USB s	PoE+ power supply at LAN interface) sensor hub (requires additional PoE+ power supply at LAN interface)
	mechanical	8-pin male M12 connector (A-coded)
	power supply	+5 V/0.1 A (USB low-power device; requires additional PoE+ power supply)
	speed	high-speed and full-speed mode in line with USB specification
	remote control protocols	USB test and measurement class (USBTMC)
	trigger input EXTernal[1]	differential (0 V/+3.3 V)
	reference clock	
	signal level	LVDS
	input frequency	20 MHz
	permissible total cable length	≤ 5 m
Ethernet interface (LAN PoE+)	mechanical	RJ-45 jack
	power supply	power over Ethernet (PoE+) class 4

10/100/1000 Mbit/s

≤ 100 m

VXI-11, HiSLIP (high-speed LAN instrument protocol), SCPI-RAW (port 5025)

speed

remote control protocols

permissible cable length

Other characteristics		
Trigger 2 I/O (TRIG2)	mechanical	SMA (f) jack
	impedance	
	input	10 k $\Omega$ or 50 $\Omega$ (software controlled)
	output	50 Ω
	signal level	
	input	compatible with 3 V or 5 V logic, max. –1 V to +6 V
	output	$\geq$ 2 V into 50 $\Omega$ load, max. 5.3 V
Reference I/O (REF)	mechanical	SMA (f) jack
	impedance	
	input/output	50 Ω
	signal level	
	input	≥ -10 dBm
	output	≥ +7 dBm
	frequency	
	input	10 MHz
	output	10 MHz
Clock I/O (CLK)	mechanical	SMA (f) jack
	impedance	
	input/output	50 Ω
	signal level	
	output	≥ -10 dBm
	frequency	
	output	119 MHz to 121 MHz
Local oscillator I/O (LO)	mechanical	SMA (f) jack
	impedance	
	input/output	50 Ω
	signal level	
	input	≥ –5 dBm
	output	≥ 0 dBm
	frequency	
	input/output	70 MHz to 6.03 GHz

General data		
Temperature ranges <sup>12)</sup>	operating temperature range	0°C to +50°C
	storage temperature range	-40°C to +85°C
Climatic resistance	damp heat	+25°C/+55°C cyclic at 95% relative humidity with restrictions: noncondensing, in line with EN 60068-2-30
Mechanical resistance	vibration	
	sinusoidal	5 Hz to 55 Hz, 0.15 mm amplitude, 1.8 g at 55 Hz, 55 Hz to 150 Hz, 0.5 g constant, in line with EN 60068-2-6
	random	8 Hz to 650 Hz, 1.9 g (RMS), in line with EN 60068-2-64
	shock	45 Hz to 2 kHz, max. 40 g shock spectrum, in line with MIL-STD-810E, method 516.4, procedure I
Air pressure	operating	795 hPa (2000 m) to 1060 hPa
	transport	566 hPa (4500 m) to 1060 hPa
Electromagnetic compatibility		harmonized standards complied with: I EN 61326-1 I EN 61326-2-1 I EN 55011 (class B)
Calibration interval	recommended	2 years
Dimensions	W × H × D	98 mm × 47 mm × 146 mm (3.85 in × 1.85 in × 5.75 in)
Weight		0.50 kg (1.10 lb)

<sup>1)</sup> By default, the discrete RBW filter selection mode (1, 2, 3, 5, ... steps) is active.

Alternatively, steplessly variable RBW can be activated for RBW < 20 MHz. The SNR in the variable RBW selection mode may be slightly lower than in the discrete RBW selection mode.

<sup>2)</sup> The sample rate is selected automatically.

<sup>30</sup> This applies to resolution bandwidths ≤ 300 kHz. For larger RBWs, spurious frequency response contributions might violate these limits at certain RF input frequencies. In addition, RBWs using zero IF mode might violate these limits due to DC offset contributions.

<sup>40</sup> Expanded uncertainty (k = 2) for absolute continuous average power measurements on CW signals centered within RBWs ≤ 10 MHz. Specifications include calibration uncertainty, aging, linearity and temperature effect.

Measurement noise must additionally be taken into account when measuring low powers. The contribution of measurement noise can be neglected below a two-sigma value of 0.01 dB.

For signal power levels less than 30 dB above the DANL at the selected RBW, a measurement bias must additionally be taken into account.

For power levels above +15 dBm/–15 dBm for 30 dB/0 dB RF input attenuation, respectively, uncertainty contributions due to intermodulation and other nonlinear effects must additionally be taken into account.

For RBWs below 1 kHz, LO phase noise contributions must additionally be taken into account.

For RBWs above 300 kHz, uncertainty contributions due to coherent spurious response frequencies (e.g. when a locked reference frequency is used) must additionally be taken into account.

When configuring the power sensor for use with an externally supplied LO signal, uncertainty contributions due to the signal integrity of the external LO signal must additionally be taken into account. Signal integrity includes properties such as frequency accuracy, and amplitude and phase stability.

Expanded uncertainty (k = 2) for relative power measurements on CW signals of identical frequency in continuous average mode for RBW ≤ 10 MHz. Specifications include aging and temperature effect.

Measurement noise must additionally be taken into account.

For signal power levels less than 30 dB above the DANL at the selected RBW, a measurement bias must additionally be taken into account.

For RBWs below 1 kHz, LO phase noise contributions must additionally be taken into account.

For RBWs above 300 kHz, uncertainty contributions due to coherent spurious response frequencies (e.g. when a locked reference frequency is used) must additionally be taken into account.

When configuring the power sensor for use with an externally supplied LO signal, uncertainty contributions due to the signal integrity of the external LO signal must additionally be taken into account. Signal integrity includes properties such as frequency accuracy, and amplitude and phase stability.

<sup>6)</sup> The IF frequency is selected automatically.

- $^{7\!\mathrm{j}}$  Measurements were performed using two-tone signals separated by 2 MHz.
- <sup>8)</sup> For average power measurements of periodic bursts.
- <sup>9)</sup> To increase measurement speed, the power sensor can be operated in buffered mode. In this mode, measurement results are stored in a buffer of user-definable size and output as a data block when the buffer is full. For further information, see application sheet "R&S®NRQ6. Fast Pulse Power Measurement" (1178824202).

 $^{\scriptscriptstyle 10)}\,$  Noise correction improves the ACLR by typ. 5 dB, depending on the level and bandwidth.

 $^{\scriptscriptstyle 11)}\,$  In I/Q trace mode, only positive trigger delays are supported.

<sup>12)</sup> The operating temperature range defines the span of ambient temperature in which the instrument complies with specifications.

# **Ordering information**

Designation	Туре	Order No.
Frequency selective power sensor	R&S®NRQ6	1421.3509.02
I/Q data interface	R&S®NRQ6-K1	1421.4705.02
Phase coherent measurements	R&S®NRQ6-K3	1421.4770.02
Accessories		
Power over Ethernet (PoE+) switch	R&S®NRP-ZAP1	1419.0829.00
USB interface cable, length: 0.75 m	R&S®NRP-ZKU	1419.0658.02
USB interface cable, length: 1.50 m	R&S®NRP-ZKU	1419.0658.03
USB interface cable, length: 3.00 m	R&S®NRP-ZKU	1419.0658.04
USB interface cable, length: 5.00 m	R&S®NRP-ZKU	1419.0658.05
Six-pole interface cable, length: 1.50 m	R&S®NRP-ZK6	1419.0664.02
Six-pole interface cable, length: 3.00 m	R&S®NRP-ZK6	1419.0664.03
Six-pole interface cable, length: 5.00 m	R&S®NRP-ZK6	1419.0664.04
USB sensor hub	R&S®NRP-Z5	1146.7740.02
Documentation		
Documentation of calibration values (DCV)	R&S®DCV-1	0240.2187.06
Hardcopy of DCV (in combination with R&S®DCV-1 only)	R&S®DCV-ZP	1173.6506.02
Accredited calibration for R&S®NRQ6 power sensor	R&S®NRP-ACA	1419.0812.00

Warranty		
Base unit		3 years
All other items <sup>1)</sup>		1 year
Options		
Extended warranty, one year	R&S®WE1	Please contact your local
Extended warranty, two years	R&S®WE2	Rohde&Schwarz sales office.
Extended warranty with calibration coverage, one year	R&S <sup>®</sup> CW1	
Extended warranty with calibration coverage, two years	R&S <sup>®</sup> CW2	
Extended warranty with accredited calibration coverage, one year	R&S®AW1	
Extended warranty with accredited calibration coverage, two years	R&S®AW2	

#### Extended warranty with a term of one and two years (WE1 and WE2)

Repairs carried out during the contract term are free of charge<sup>2</sup>). Necessary calibration and adjustments carried out during repairs are also covered.

#### Extended warranty with calibration coverage (CW1 and CW2)

Enhance your extended warranty by adding calibration coverage at a package price. This package ensures that your Rohde&Schwarz product is regularly calibrated, inspected and maintained during the term of the contract. It includes all repairs<sup>2)</sup> and calibration at the recommended intervals as well as any calibration carried out during repairs or option upgrades.

#### Extended warranty with accredited calibration (AW1 and AW2)

Enhance your extended warranty by adding accredited calibration coverage at a package price. This package ensures that your Rohde&Schwarz product is regularly calibrated under accreditation, inspected and maintained during the term of the contract. It includes all repairs<sup>2)</sup> and accredited calibration at the recommended intervals as well as any accredited calibration carried out during repairs or option upgrades.

<sup>1)</sup> For options that are installed, the remaining base unit warranty applies if longer than 1 year. Exception: all batteries have a 1 year warranty.

<sup>2)</sup> Excluding defects caused by incorrect operation or handling and force majeure. Wear-and-tear parts are not included.

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- Long-term dependability

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